

<b>Search Notes</b> 				<b>Application/Control No.</b> 10/672,500 <b>Examiner</b> Paul Dinh	<b>Applicant(s)/Patent under Reexamination</b> BEHNEN ET AL. <b>Art Unit</b> 2825	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
Class	Subclass	Date	Examiner			
716	1-2,4-6,18	11/5/2004	PD			
above	update	3/28/2005	PD			
<b>INTERFERENCE SEARCHED</b>						
Class	Subclass	Date	Examiner			